

<b>Notice of References Cited</b>	Application/Control No. 09/890,266	Applicant(s)/Patent Under Reexamination OHNO ET AL.	
	Examiner MISOOK YU, Ph.D.	Art Unit 1642	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,861,159	01-1999	Pardoll et al.	424/184.1
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	J	US-			
	K	US-			
	L	US-			
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**FOREIGN PATENT DOCUMENTS**

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	N					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Entry of "microparticle in Meririam-Webster Online downloaded on 3/13/2005 from url>>www.m-w.com
	V	
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